

Physical Effects of Aleph's Semi-implicit Particle-in-cell Algorithm

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Abstract

System-scale kinetic simulation of high-density plasmas in vacuum arc discharges is challenging due to stability constraints placed on the timestep and mesh size in conventional particle-in-cell (PIC) methods. In recent years, an energy-conserving semi-implicit PIC[1,2] (SIPIC) scheme has been implemented in the low-temperature plasma simulation code Aleph [3] that allows the circumvention of the finite-grid instability (FGI) and relaxes the timestep requirement that the electron plasma frequency be resolved. However, how/if the semi-implicit scheme affects the underlying physics of the discharge is not well understood. In this work, the influence of SIPIC on particular quantities of interest in vacuum-arc discharges is investigated and comparisons between analytical theory and explicit electrostatic PIC are made where possible.

Introduction

Energy-conserving Semi-implicit PIC

$$\begin{aligned} \dot{\mathbf{x}} &= \frac{\mathbf{p}_p}{m_p}, \\ m_p \dot{\mathbf{v}}_p &= -\sum_v \nabla S_v(\mathbf{x}_p) \phi_v, \\ \nabla \cdot \left(1 + C \frac{e^2 \Delta t^2}{4 m_e \epsilon_0} \bar{n}_e \right) \nabla \phi &= -\frac{\rho}{\epsilon_0}, \\ \rho &= \frac{1}{V_v} \sum_p S_v(\mathbf{x}_p) q_p \end{aligned}$$

For $|\mathbf{u}_e| < v_{th,e}$, SIPIC is stable against aliasing instabilities
 $\rightarrow \Delta x > \lambda_{De}$ can be used

If $C \geq 1$, the electron plasma mode is stabilized
 $\rightarrow \Delta t > \omega_{pe}^{-1}$ can be used

Physical Effects

'Stretches' the Debye length

$$\lambda_{De}^{SI} = \sqrt{\frac{e^2 k_B T_e}{n_e e^2}}, \quad \epsilon^{SI} = \epsilon_0 \left(1 + C \frac{e^2 \Delta t^2}{4 m_e \epsilon_0} n_e \right)$$

'Contracts' plasma frequency

$$\omega_{pe}^{SI} = \sqrt{\frac{n_e e^2}{\epsilon^{SI} m_e}},$$

SI cold-plasma dispersion relation (fluid-perspective)

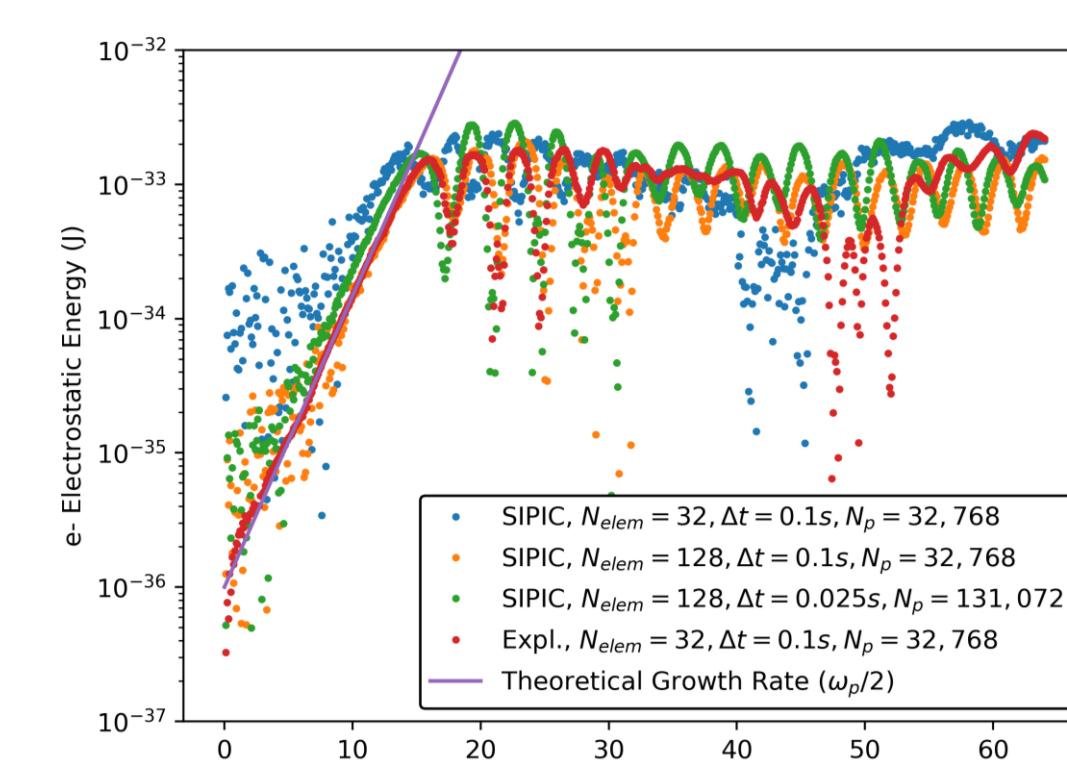
$$1 - \sum_{\sigma} \frac{\omega_{pe}^{SI 2}}{(\omega - \mathbf{u}_0 \cdot \mathbf{k})^2} = 0$$

$\omega_{pe} \rightarrow \omega_{pe}^{SI}$ in growth rates derived from fluid equations

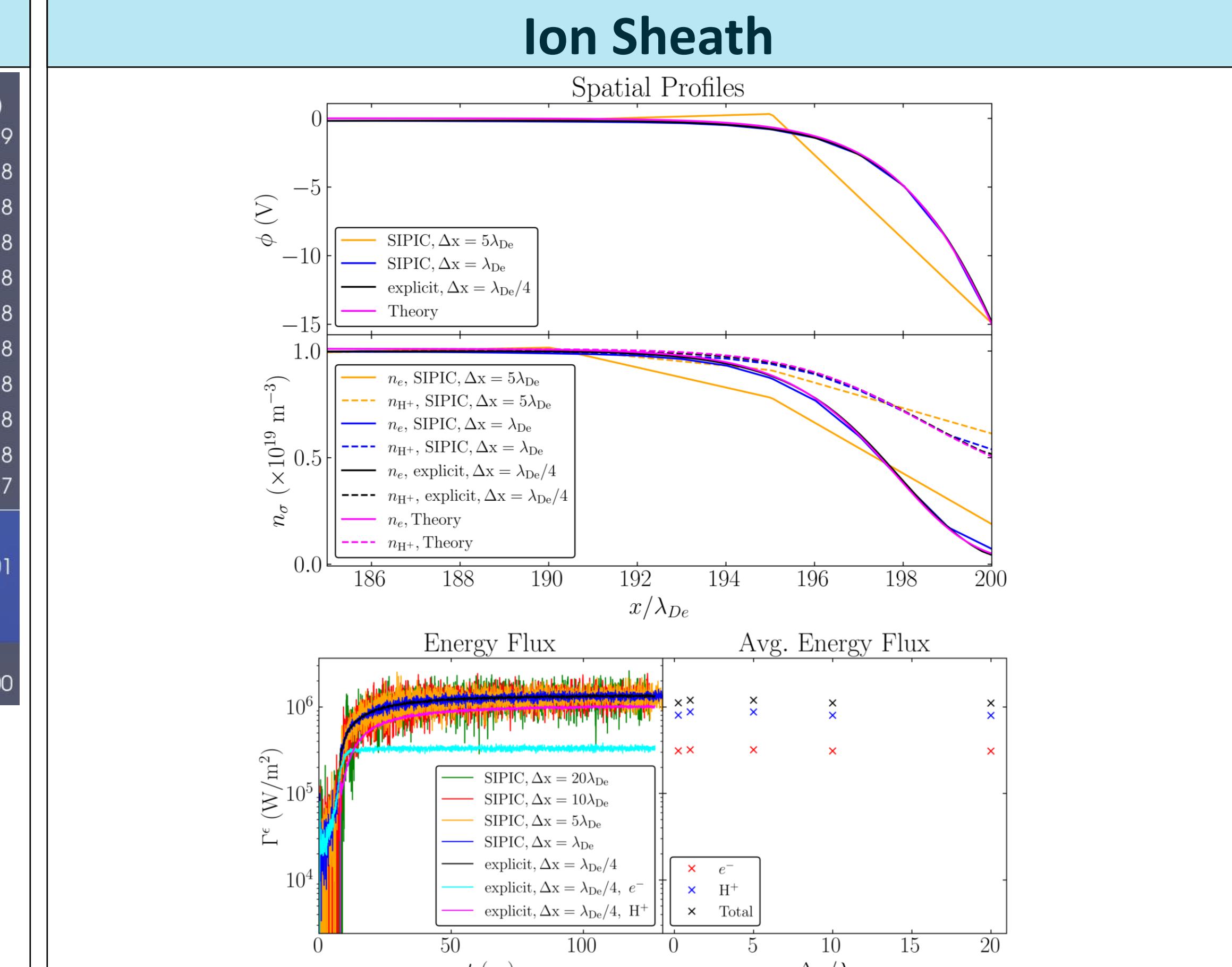
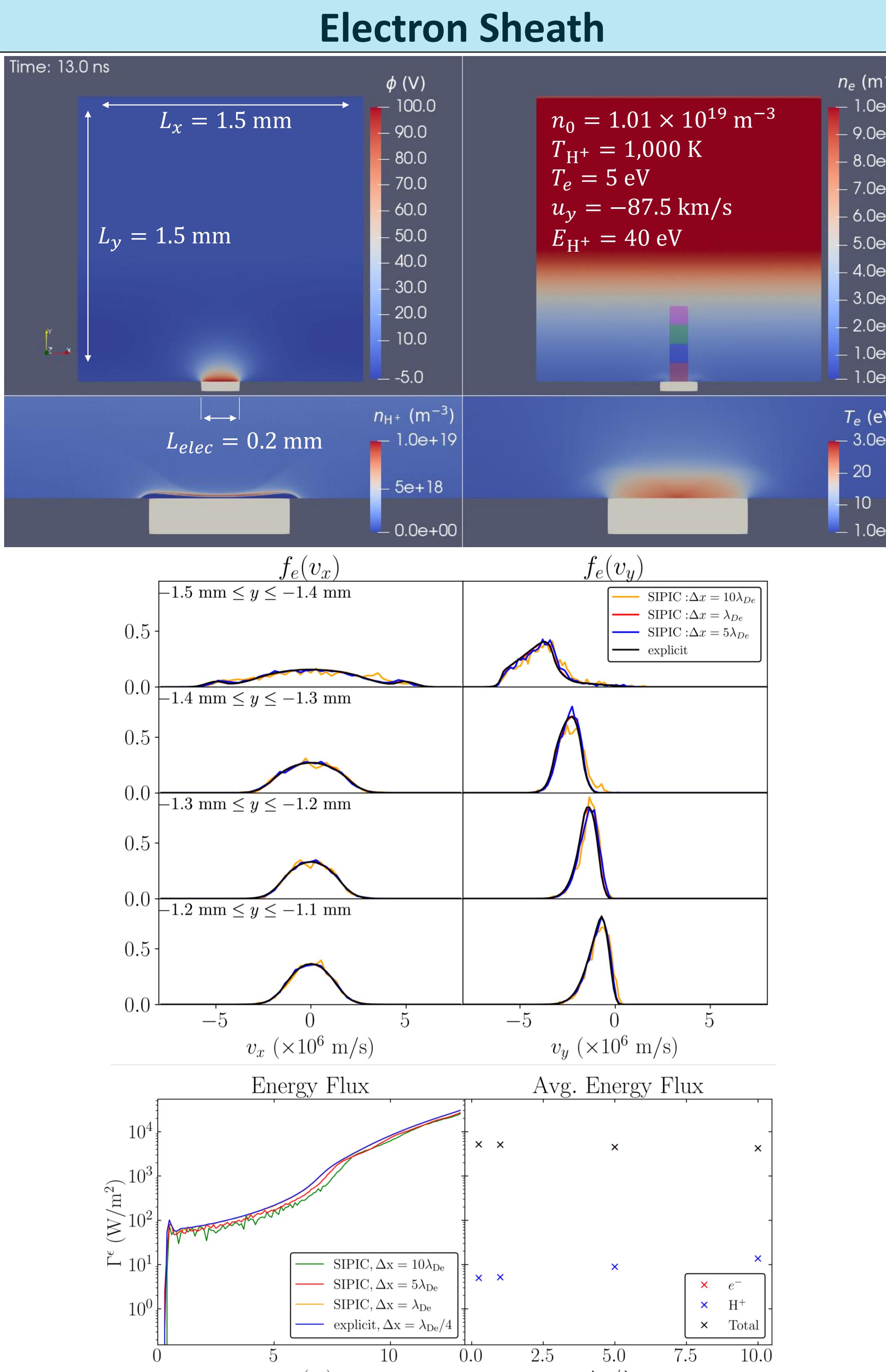
Question

Can we use this algorithm to accurately model surface-plasma interactions in high-density plasma discharges?

Cold Electron-Electron Two-Stream Instability



- SIPIC captures growth rate when using the same numerical parameters
 - Much more noisy intrinsically for this problem
 - Can 'refine away' issues
 - element size has biggest effect
- Reason for intrinsic noise is TBD
 - $T_e = 0 \text{ K} \rightarrow |\mathbf{u}_e| > v_{the}$, so FGI may play a role here?



- The sheath is poorly resolved spatially as the mesh size increases
 - Mesh refinement near electrodes might be beneficial in real problems
- Energy fluxes are comparable with explicit PIC and SIPIC despite poor resolution of the sheath
- Potential drop from plasma-bulk to wall is the same

Conclusion

Aleph's SIPIC model stretches the Debye length (and/or contracts ω_p)

- Allows for $\Delta t > \omega_{pe}^{-1}$ and $\Delta x > \lambda_{De}$
- Accurately models dense plasmas at a fraction of the computational cost

Regardless of element size, for (electron/ion) sheaths SIPIC shows

- Good agreement of EVDFs near biased electrodes with PIC
- Good agreement of energy fluxes to walls/electrodes

For the cold e-e two-stream instability

- SIPIC captures the growth rate
- Need to refine mesh is troublesome, but may be related to FGI in energy-conserving PIC schemes
- SIPIC may benefit from noise-reducing techniques (C1 elements, time-filtering, etc.)

References

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